

General Description

The WST3078 is the highest performance trench N-ch and P-ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(on)}$ and gate charge for most of the small power switching and load switch applications.

The WST3078 meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent C_{dV}/dt effect decline
- Green Device Available

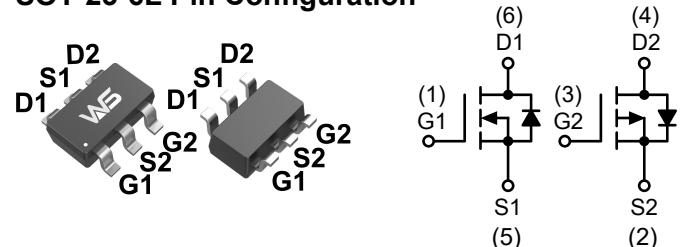
Product Summary

BV_{DSS}	$R_{DS(on)}$	I_D
30V	32mΩ	3.5A
-30V	78mΩ	-3A

Applications

- High Frequency Point-of-Load Synchronous Small power switching for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOT-23-6L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating		Units
		N-Channel	P-Channel	
V_{DS}	Drain-Source Voltage	30	-30	V
V_{GS}	Gate-Source Voltage	± 20	± 20	V
$I_D@T_c=25^\circ C$	Continuous Drain Current, $V_{GS} @ 4.5V^1$	3.5	-3	A
$I_D@T_c=70^\circ C$	Continuous Drain Current, $V_{GS} @ 4.5V^1$	3.0	-2.4	A
I_{DM}	Pulsed Drain Current ²	19	-12	A
$P_D@T_A=25^\circ C$	Total Power Dissipation ³	1.4	1.4	W
T_{STG}	Storage Temperature Range	-55 to 150	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	-55 to 150	°C

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient ¹	---	125	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	---	90	°C/W

N-Channel Electrical Characteristics ($T_J=25^{\circ}\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	30	---	---	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C , $I_D=1\text{mA}$	---	0.025	---	$\text{V}/^{\circ}\text{C}$
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance ²	$V_{\text{GS}}=10\text{V}$, $I_D=2.7\text{A}$	---	32	50	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$, $I_D=2\text{A}$	---	56	68	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=250\mu\text{A}$	1.3	1.6	2.5	V
$\Delta V_{\text{GS}(\text{th})}$	$V_{\text{GS}(\text{th})}$ Temperature Coefficient		---	-2.54	---	$\text{mV}/^{\circ}\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=24\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^{\circ}\text{C}$	---	---	1	uA
		$V_{\text{DS}}=24\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=85^{\circ}\text{C}$	---	---	30	
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 10	uA
g_{fs}	Forward Transconductance	$V_{\text{DS}}=5\text{V}$, $I_D=2\text{A}$	---	11	---	S
R_g	Gate Resistance	$V_{\text{DS}}=0\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	2.3	---	Ω
Q_g	Total Gate Charge (4.5V)	$V_{\text{DS}}=15\text{V}$, $V_{\text{GS}}=10\text{V}$, $I_D=2\text{A}$	---	3	---	nC
Q_{gs}	Gate-Source Charge		---	1.1	---	
Q_{gd}	Gate-Drain Charge		---	1.5	---	
$T_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}}=10\text{V}$, $V_{\text{GEN}}=4.5\text{V}$, $R_G=6\Omega$ $I_D=2\text{A}$ $R_L=10\Omega$	---	5.3	8	ns
T_r	Rise Time		---	11	16	
$T_{\text{d}(\text{off})}$	Turn-Off Delay Time		---	2.6	4	
T_f	Fall Time		---	12	17	
C_{iss}	Input Capacitance	$V_{\text{DS}}=15\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	215	---	pF
C_{oss}	Output Capacitance		---	37	---	
C_{rss}	Reverse Transfer Capacitance		---	28	---	

Drain-Source Body Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_S	Continuous Source-Drain Diode Current ^{1,4}	$V_G=V_D=0\text{V}$, Force Current	---	---	1.0	A
I_{SM}	Pulsed Diode Forward Current ^{2,4}		---	---	5	A
V_{SD}	Body Diode Voltage ²	$V_{\text{GS}}=0\text{V}$, $I_S=1\text{A}$, $T_J=25^{\circ}\text{C}$	---	0.75	1.1	V
t_{rr}	Reverse Recovery Time	$I_F=5\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$, $T_J=25^{\circ}\text{C}$	---	9.2	---	nS
Q_{rr}	Reverse Recovery Charge		---	4.3	---	nC

Note :

- 1.The data tested by Surface Mounted on 1in2 pad area..
- 2.The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- 3.The power dissipation is limited by 150°C junction temperature
- 4.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

P-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=-250\mu\text{A}$	-30	---	---	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C , $I_D=-1\text{mA}$	---	-0.013	---	$\text{V}/^\circ\text{C}$
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance ²	$V_{\text{GS}}=-10\text{V}$, $I_D=-2\text{A}$	---	78	100	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}$, $I_D=-1.5\text{A}$	---	120	170	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=-250\mu\text{A}$	-1.3	-1.6	-2.5	V
$\Delta V_{\text{GS}(\text{th})}$	$V_{\text{GS}(\text{th})}$ Temperature Coefficient		---	2.3	---	$\text{mV}/^\circ\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=-24\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	-1	uA
		$V_{\text{DS}}=-24\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=85^\circ\text{C}$	---	---	-30	
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 10	uA
g_{fs}	Forward Transconductance	$V_{\text{DS}}=-5\text{V}$, $I_D=-2\text{A}$	---	3.8	---	S
Q_g	Total Gate Charge (-4.5V)	$V_{\text{DS}}=-15\text{V}$, $V_{\text{GS}}=-10\text{V}$, $I_D=-2\text{A}$	---	3.3	---	nC
Q_{gs}	Gate-Source Charge		---	1.1	---	
Q_{gd}	Gate-Drain Charge		---	1.1	---	
$T_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}}=-15\text{V}$, $V_{\text{GEN}}=-10\text{V}$, $R_G=6\Omega$ $I_D=-1\text{A}$, $R_L=15\Omega$.	---	5.3	---	ns
T_r	Rise Time		---	9.3	---	
$T_{\text{d}(\text{off})}$	Turn-Off Delay Time		---	3.6	---	
T_f	Fall Time		---	15.4	---	
C_{iss}	Input Capacitance	$V_{\text{DS}}=-15\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	229	---	pF
C_{oss}	Output Capacitance		---	42	---	
C_{rss}	Reverse Transfer Capacitance		---	33	---	

Drain-Source Body Diode Characteristics

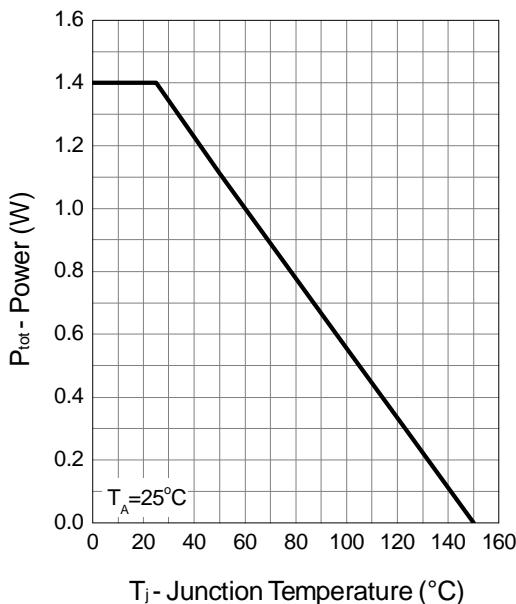
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source-Drain Diode Current ^{1,4}	$V_G=V_D=0\text{V}$, Force Current	---	---	-3.2	A
I_{SM}	Pulsed Diode Forward Current ^{2,4}		---	---	-15	A
V_{SD}	Body Diode Voltage ²	$V_{\text{GS}}=0\text{V}$, $I_s=-1\text{A}$, $T_J=25^\circ\text{C}$	---	0.75	-1.1	V
t_{rr}	Reverse Recovery Time	$I_F=-2\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$, $T_J=25^\circ\text{C}$	---	19	---	nS
Q_{rr}	Reverse Recovery Charge		---	14	---	nC

Note :

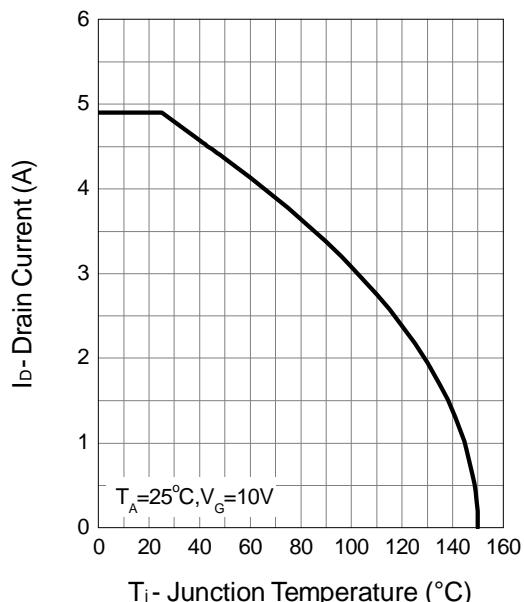
- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- 3.The power dissipation is limited by 150°C junction temperature
- 4.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

N-Channel Typical Characteristics

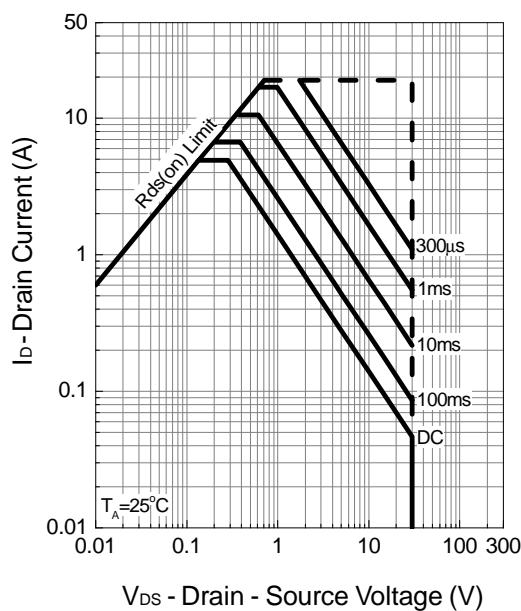
Power Dissipation



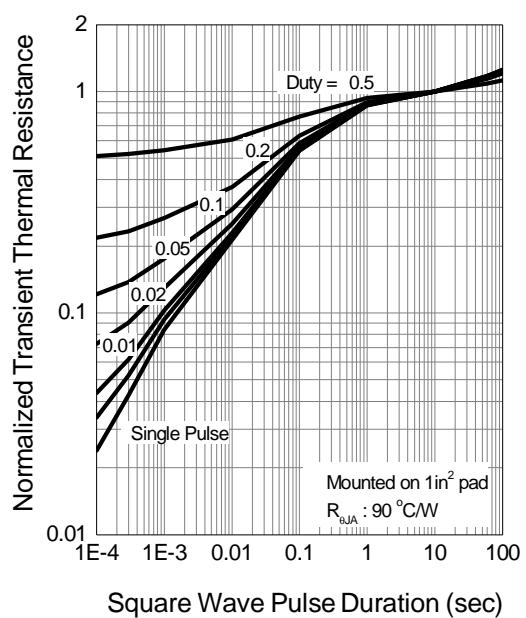
Drain Current

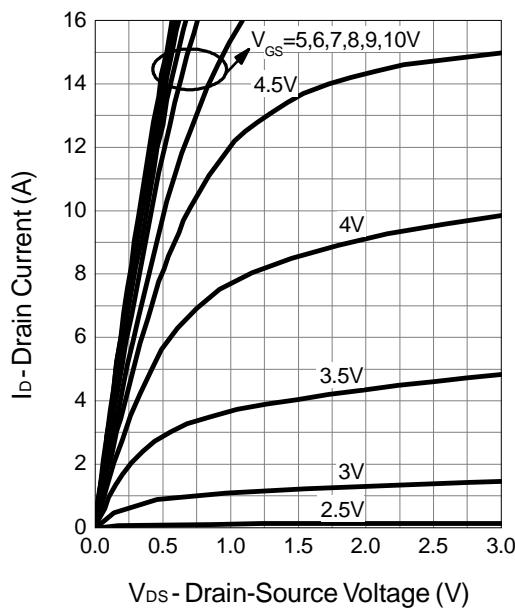
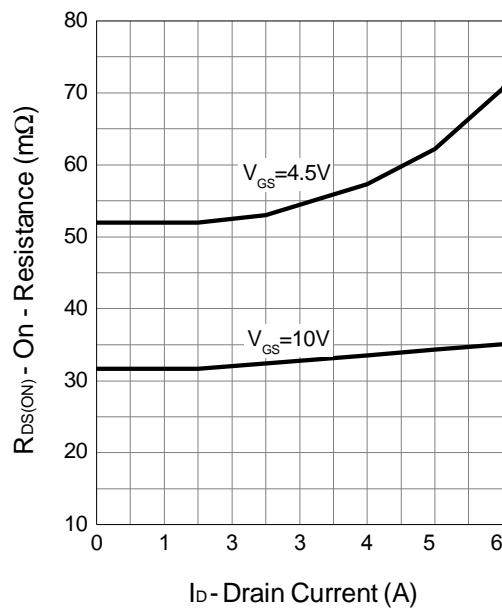
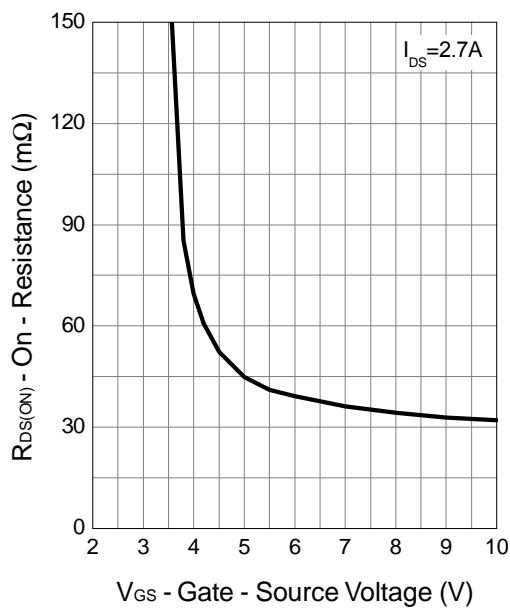
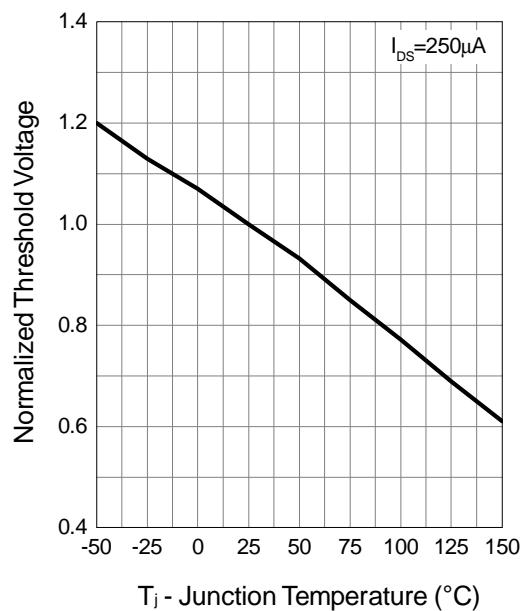


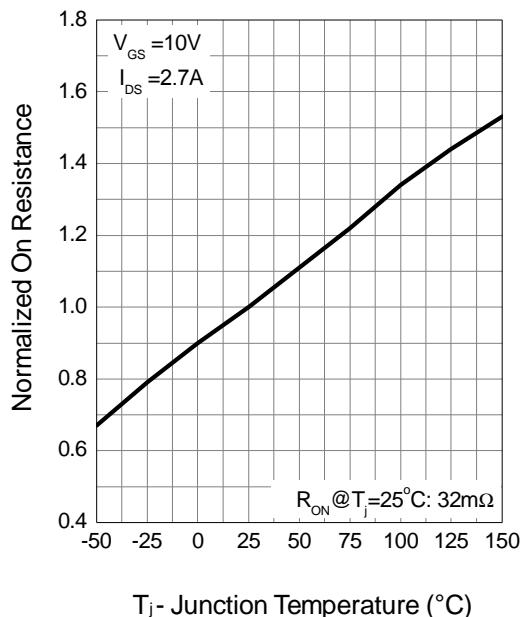
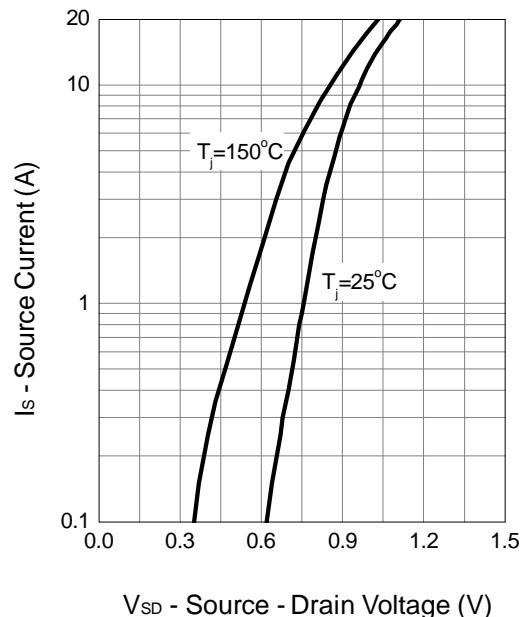
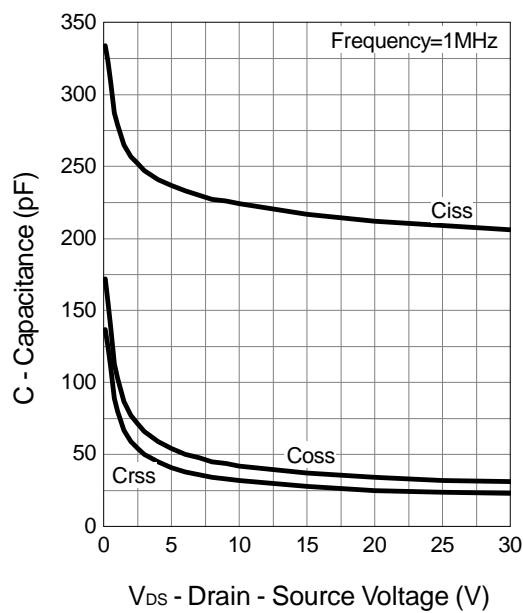
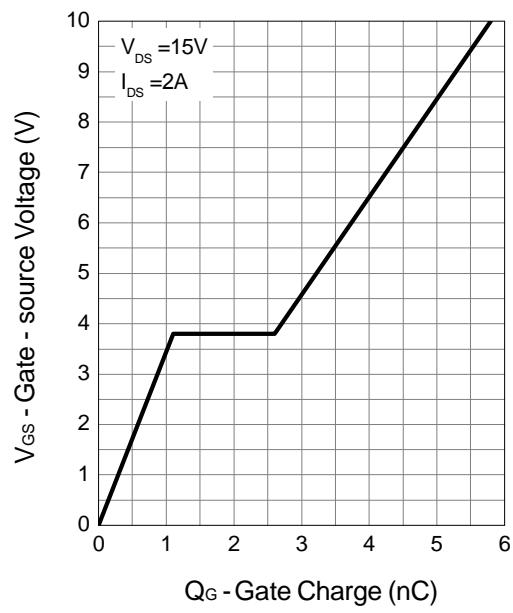
Safe Operation Area



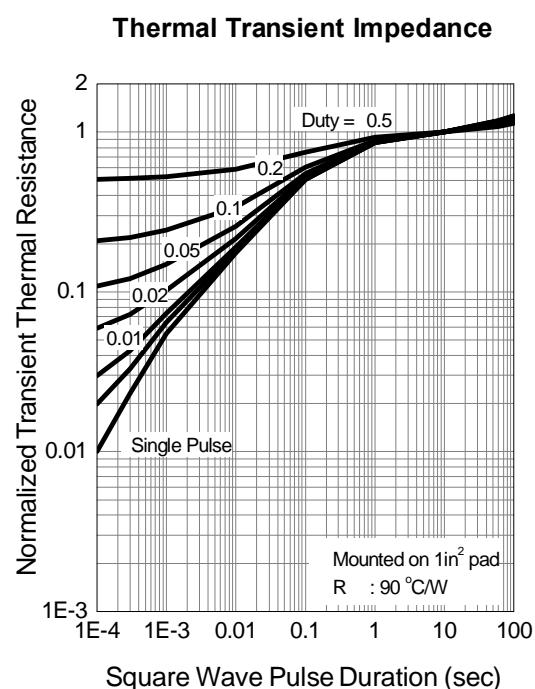
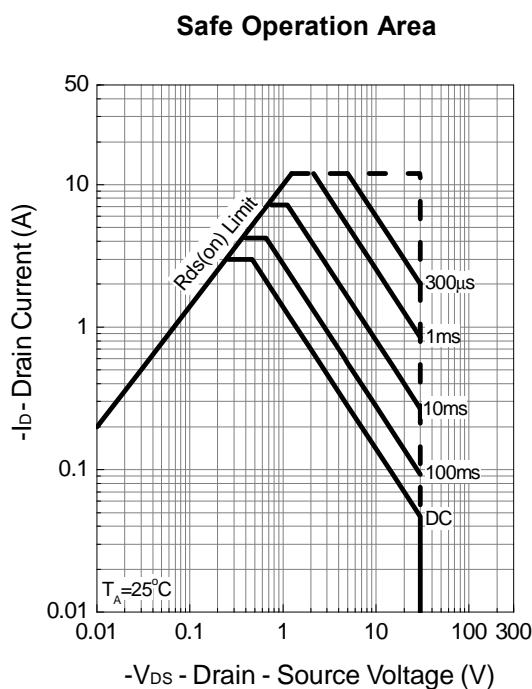
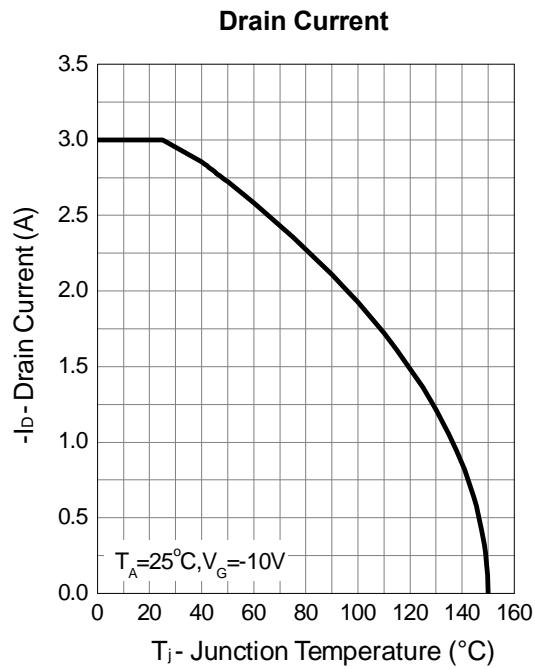
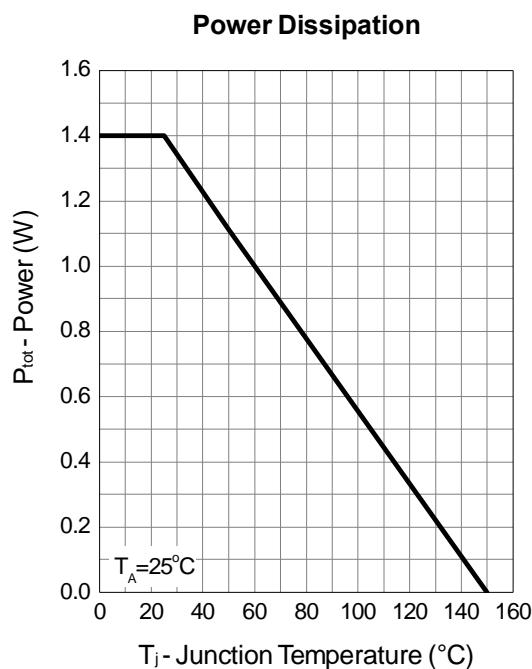
Thermal Transient Impedance

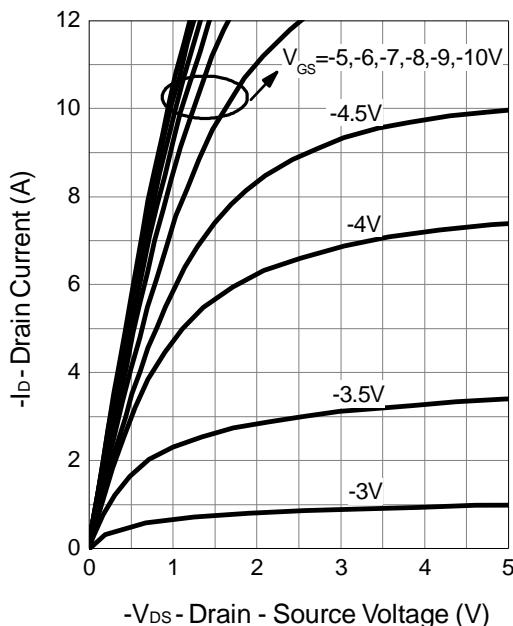
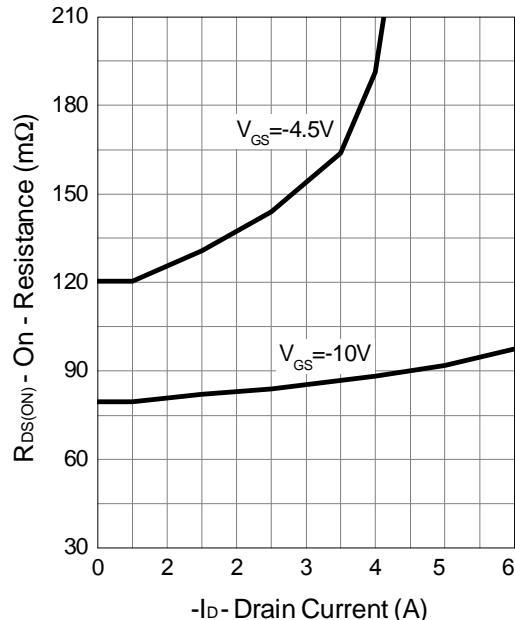
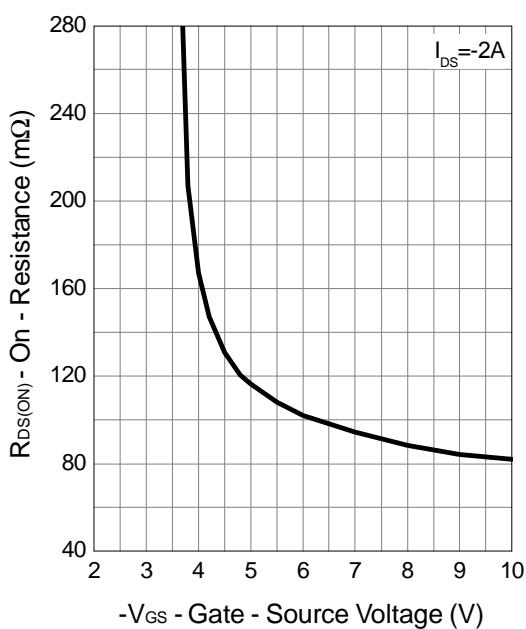
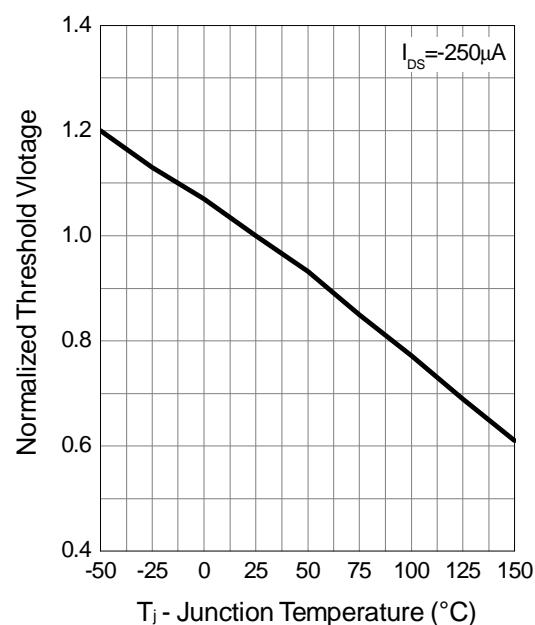


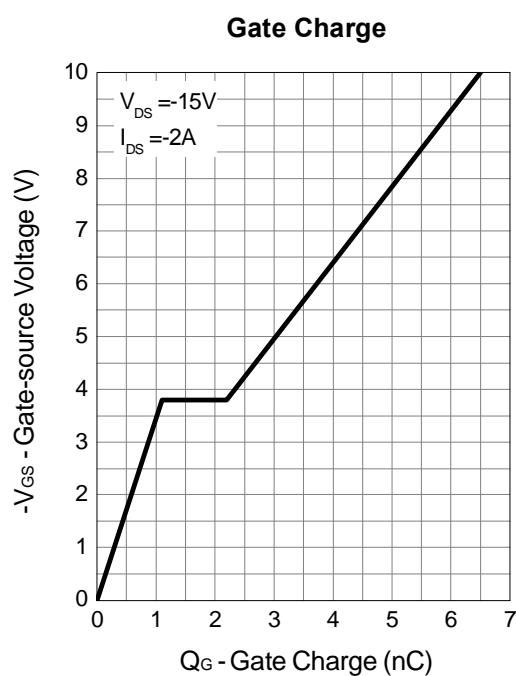
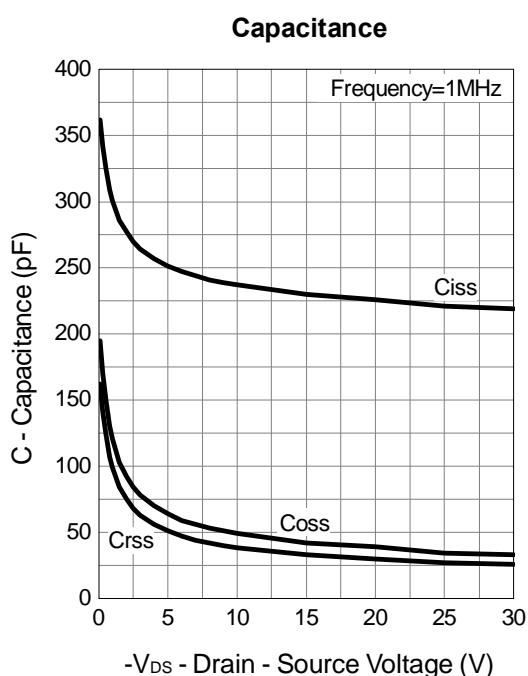
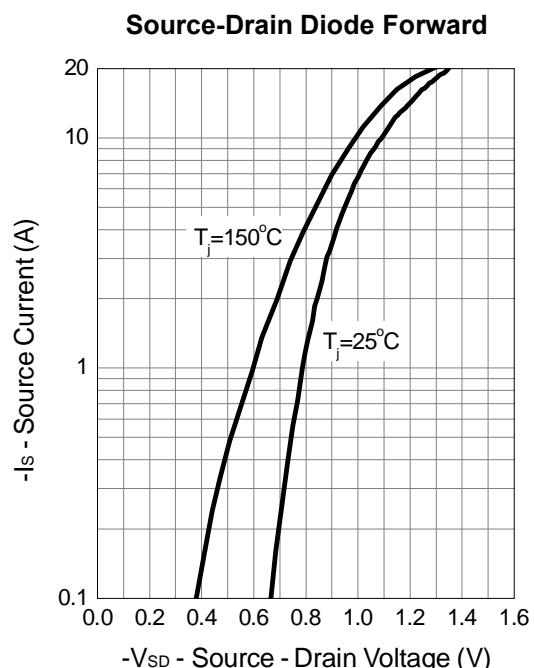
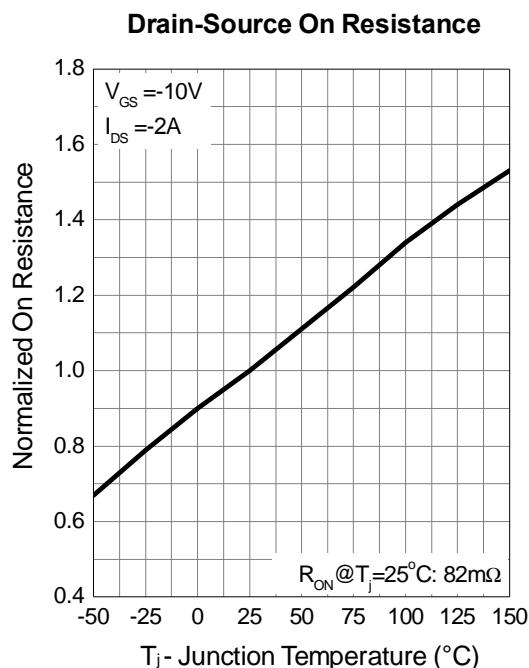
Output Characteristics

Drain-Source On Resistance

Gate-Source On Resistance

Gate Threshold Voltage


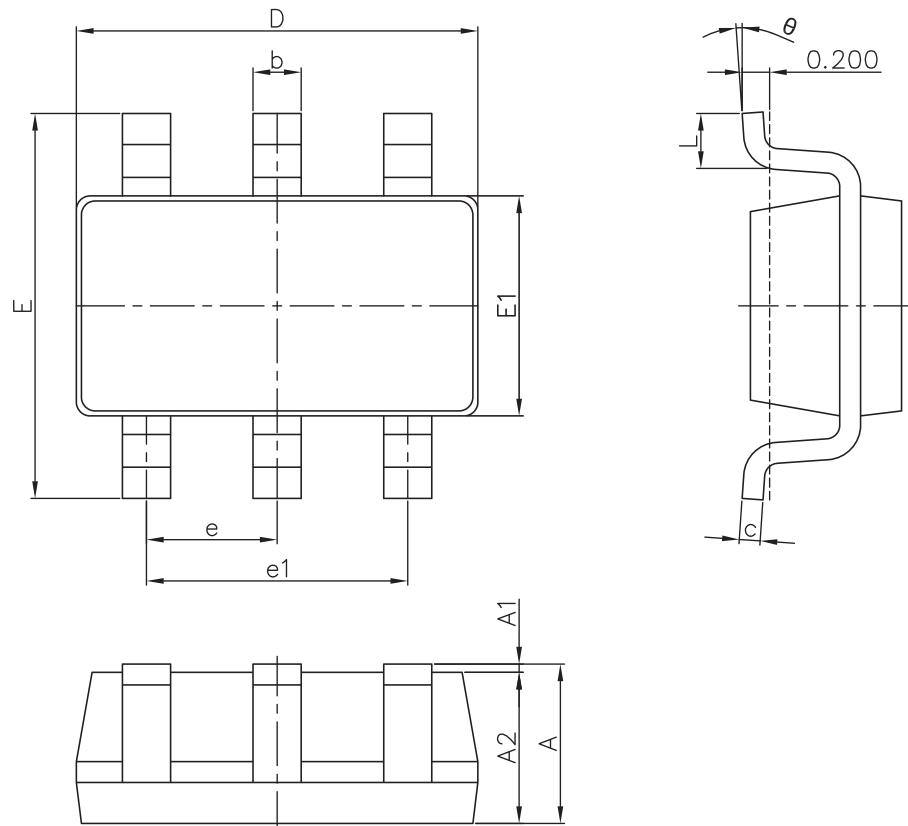
Drain-Source On Resistance

Source-Drain Diode Forward

Capacitance

Gate Charge


P-Channel Typical Characteristics



Output Characteristics

Drain-Source On Resistance

Gate-Source On Resistance

Gate Threshold Voltage




Packaging information


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
e	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°



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